

FCC Test Report

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Test Model: Open-Q 660 uSOM

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FCC Registration / 788550 / TW0003

Designation Number:



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Release Control Record

Issue No.	Description	Date Issued
RFBHAT-WTW-P21030696	Original Release	Sep. 10, 2021
RFBHAT-WTW-P21030696 R1	Revise Applicant	Nov. 08, 2021



1 Certificate of Conformity

Product:	Open-Q 660 uSOM
Brand:	Lantronix
Test Model:	Open-Q 660 uSOM
Sample Status:	Engineering Sample
Applicant:	Lantronix, Inc.
Test Date:	Apr. 08 ~ Jun. 10, 2021
Standards:	47 CFR FCC Part 15, Subpart C (Section 15.247)
	ANSI C63.10:2013

The above equipment has been tested by **Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch**, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's RF characteristics under the conditions specified in this report.

Lena

Prepared by :

Lena Wang / Specialist

Date: Nov. 08, 2021

Rh>C-

Date: Nov. 08, 2021

Approved by :

Dylan Chiou / Senior Engineer



2 Summary of Test Results

	47 CFR FCC Part 15, Subpart C (Section 15.247)								
FCC Clause	Test Item	Result	Remarks						
15.207	AC Power Conducted Emission	Pass	Meet the requirement of limit. Minimum passing margin is -24.83 dB at 0.40179 MHz.						
15.247(a)(1) (iii)	Number of Hopping Frequency Used	Pass	Meet the requirement of limit.						
15.247(a)(1) (iii)	Dwell Time on Each Channel	Pass	Meet the requirement of limit.						
15.247(a)(1)	 Hopping Channel Separation Spectrum Bandwidth of a Frequency Hopping Sequence Spread Spectrum System 	Pass	Meet the requirement of limit.						
15.247(a)(1)	Maximum Peak Output Power	Pass	Meet the requirement of limit.						
	Occupied Bandwidth Measurement	Pass	Reference only						
15.205 & 209	15.205 & 209 Radiated Emissions		Meet the requirement of limit. Minimum passing margin is -5.0 dB at 2390.00 MHz.						
15.247(d)	Band Edge Measurement	Pass	Meet the requirement of limit.						
15.247(d)	Antenna Port Emission	Pass	Meet the requirement of limit.						
15.203	Antenna Requirement	Pass	Antenna connector is U.FL.						

Note:

- If the Frequency Hopping System operating in 2400-2483.5 MHz band and the output power less than 125 mW. The hopping channel carrier frequencies separated by a minimum of 25 kHz or two-thirds of the 20 dB bandwidth of hopping channel whichever is greater.
- 2. For 2.4G band compliance with rule 15.247(d) of the band-edge items, the test plots were recorded in Annex A. Test Procedures refer to report 4.1.3.
- 3. Determining compliance based on the results of the compliance measurement, not taking into account measurement instrumentation uncertainty.

2.1 Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

Measurement	Frequency	Expanded Uncertainty (k=2) (±)
Conducted Emissions at mains ports	150 kHz ~ 30 MHz	2.79 dB
	9 kHz ~ 30 MHz	3.04 dB
Radiated Emissions up to 1 GHz	30 MHz ~ 200 MHz	2.93 dB
	200 MHz ~ 1000 MHz	2.95 dB
Radiated Emissions above 1 GHz	1 GHz ~ 18 GHz	2.26 dB
	18 GHz ~ 40 GHz	1.94 dB



2.2 Modification Record

There were no modifications required for compliance.



3 General Information

3.1 General Description of EUT

Product	Open-Q 660 uSOM
Brand	Lantronix
Test Model	Open-Q 660 uSOM
Status of EUT	Engineering Sample
Power Supply Rating	12 Vdc (Adapter)
Modulation Type	GFSK, π/4-DQPSK, 8DPSK
Transfer Rate	1/2/3 Mbps
Operating Frequency	2402 ~ 2480 MHz
Number of Channel	79
Output Power	19.187 mW
Antenna Type	Refer to Note as below
Antenna Connector	Refer to Note as below
Accessory Device	Refer to Note as below
Data Cable Supplied	N/A

Note:

1. The following antennas were provided to the EUT.

Ant. Type	Ant. Type Flexible Dipole Antenna							
Connecter Type U.FL								
	Antenna Gain (dBi)							
Item	2.4~2.5G	4.9~5.8G						
Ant 1	3.32	6.11						
Ant 2	3.32	6.11						

2. The above Antenna information is declared by manufacturer and for more detailed features description, please refer to the manufacturer's specifications, the laboratory shall not be held responsible.

3. The above EUT information is declared by manufacturer and for more detailed features description, please refers to the manufacturer's specifications or User's Manual.

4. BT, 2.4G and 5GHz WLAN can transmit simultaneously. The emission of the simultaneous operation has been evaluated and no non-compliance was found.



3.2 Description of Test Modes

79 channels are provided to this EUT:

Channel	Freq. (MHz)						
0	2402	20	2422	40	2442	60	2462
1	2403	21	2423	41	2443	61	2463
2	2404	22	2424	42	2444	62	2464
3	2405	23	2425	43	2445	63	2465
4	2406	24	2426	44	2446	64	2466
5	2407	25	2427	45	2447	65	2467
6	2408	26	2428	46	2448	66	2468
7	2409	27	2429	47	2449	67	2469
8	2410	28	2430	48	2450	68	2470
9	2411	29	2431	49	2451	69	2471
10	2412	30	2432	50	2452	70	2472
11	2413	31	2433	51	2453	71	2473
12	2414	32	2434	52	2454	72	2474
13	2415	33	2435	53	2455	73	2475
14	2416	34	2436	54	2456	74	2476
15	2417	35	2437	55	2457	75	2477
16	2418	36	2438	56	2458	76	2478
17	2419	37	2439	57	2459	77	2479
18	2420	38	2440	58	2460	78	2480
19	2421	39	2441	59	2461		



3.2.1 Test Mode Applicability and Tested Channel Detail

EUT Configure		Applic	able To		
Mode	RE≥1G	RE<1G	PLC	APCM	Description
-	\checkmark	\checkmark	\checkmark	\checkmark	-
Where R	RE≥1G: Radiated Emission above 1 GHz				adiated Emission below 1 GHz
Р	PLC: Power Line Conducted Emission				tenna Port Conducted Measurement
•• ·					

Note:

1. The EUT had been pre-tested on the positioned of each 3 axis. The worst case was found when positioned on **Z-plane**.

2. "-" means no effect.

3.Radiated emission test (below 1GHz) and power line conducted emission test items chosen the worst fundamental frequency emission level.

Radiated Emission Test (Above 1 GHz):

Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates and antenna ports (if EUT with antenna diversity architecture).

Following channel(s) was (were) selected for the final test as listed below.

EUT Configure Mode	Available Channel	Tested Channel	Modulation Technology	Modulation Type	Packet Type
-	0 to 78	0, 39, 78	FHSS	GFSK	DH5
	0 to 78	0, 39, 78	FHSS	8DPSK	3DH5

Radiated Emission Test (Below 1 GHz):

- Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates and antenna ports (if EUT with antenna diversity architecture).
- Following channel(s) was (were) selected for the final test as listed below.

EUT Configure Mode		Available Channel	Tested Channel	Modulation Technology	Modulation Type	Packet Type
Ī	-	0 to 78	0	FHSS	GFSK	DH5

Power Line Conducted Emission Test:

Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates and antenna ports (if EUT with antenna diversity architecture).

Following channel(s) was (were) selected for the final test as listed below.

EUT Configure Mode	Available Channel	Tested Channel	Modulation Technology	Modulation Type	Packet Type	
-	0 to 78	0	FHSS	GFSK	DH5	



Antenna Port Conducted Measurement:

- This item includes all test value of each mode, but only includes spectrum plot of worst value of each mode.
- Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates and antenna ports (if EUT with antenna diversity architecture).

Following channel(s) was (were) selected for the final test as listed below.

EUT Configure Mode	Available Channel	Tested Channel	Modulation Technology	Modulation Type	Packet Type	
-	0 to 78	0, 39, 78	FHSS	GFSK	DH5	
-	0 to 78	0, 39, 78	FHSS	8DPSK	3DH5	

Test Condition:

Applicable To	Environmental Conditions	Input Power	Tested by	
RE≥1G	25 deg. C, 65 % RH	120 Vac, 60 Hz	Adair Peng	
RE<1G	25 deg. C, 65 % RH	120 Vac, 60 Hz	Adair Peng	
PLC	25 deg. C, 65 % RH	120 Vac, 60 Hz	Edison Lee	
APCM	25 deg. C, 65 % RH	120 Vac, 60 Hz	Ivan Tseng	

3.3 Duty Cycle of Test Signal

Duty cycle = 2.94/100 = 0.0294, Duty factor = $20 * \log(0.0294) = -30.63$

Spectrum Anal Swept SA		Spectrum Analyzer 2 Swept SA	+				•	Sweep	· 🛞	Spectrum A Swept SA		Spectrum Analyzer 2 Swept SA					\$	Marker	- *
· · · · ·	Input: RF Coupling: DC Align: Auto	Input Z: 50 Ω Corr CCorr RCal Freq Ref. Int (S)	#Atten: 0 dB	PNO: Fast Gate: Off IF Gain: High	Avg Type: Log-Power Trig: Free Run	123456 WWWWWW	Sweep Time 100.0 ms	e	Sweep/ Control	L -•	HT Input. RF Coupling: D Align: Auto	Corr CCorr RCal Freq Ref: Int (S)	#Allen. 0 dB	PNO. Fast Cate: Off IF Gain: High	Avg Type. Log-Power Trig: Free Run	₩ ₩ ₩₩₩₩	Select Mark Marker 1	er	•
1 Spectrum Scale/Div 10 o	•		Ref Level 86.99 d	Sig Track. Off		20.40 ms .59 dBµV	Sweep Time Annotation Normal	•	Sweep Config	1 Spectrum Scale/Div	T O dB		Ref Level 86.9	Sig Track. Off	ΔMkr1	2.940 ms -1.07 dB	Marker ∆ T 2.94000 m	s	Settings Peak
Log		<u>}1</u>	Rei Level 30.89 (10µv			Auto Man			Log	U UB		Rei Level co.s	a apha		-1.07 0.5	Marker Mo	de	Search Pk Search
67.0							Sweep / Me Continu Single			67.0							O Delta (J		Config Properties
57.0 47.0							Res	itart		57.0 47.0	- P						Fixed Off		Marker Function
37.0										37.0			142				Delta (Rese		Marker→
17.0					19 19 19 19 19 19 19 19 19 19 19 19 19 1					27.0 <mark>सनम्बन्</mark> 17.0	17111X2				la geographic terre til te	an an the second	Marker Tab On Off	le	Counter
6.99										6.99 1.1	н.			e ne tilt at tå tilt.		ur . Iul.	K Marker Diaj		
Center 2.4020		illus and	Wideo BW 8.01	<mark>u kini oruhu</mark> Mez	andrent docate o	Span 0 Hz				Center 2.4	2000000 GHz		#Video BW 8	.0 MHz		Span 0 Hz	Couple Ma	kers Off rkers	
#Res BW (-60		Apr 09, 2021 9:23:38 AM	ÐA		Sweep 100 m						-6dB) 3.00 MH	Apr 09, 2021 9:24:35 AM			Sweep 10.0	ms (1001 pts)	On Off		



3.4 Description of Support Units

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks	
А	Notebook	DELL	Latitude E6420	HPFC5Q1	N/A	-	
В	Jig	Jig N/A		N/A	N/A	Provided by client	
С			YHY-12003000 N/A		N/A	Provided by client	

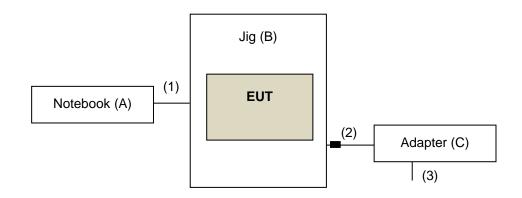
Note:

1. All power cords of the above support units are non-shielded (1.8m).

2. Item A acted as a communication partner to transfer data.

ID	Cable Descriptions	Qty.	Length (m)	Shielding (Yes/No)	Cores (Qty.)	Remarks
1.	Type C USB Cable	1	1	Y	0	Provided by client
2.	Adapter Cable	1	1.2	Y	1	Provided by client
3.	Power Cable	1	1.15	N	0	Provided by client

3.4.1 Configuration of System under Test



3.5 General Description of Applied Standards and References

The EUT is a RF Product. According to the specifications of the manufacturer, it must comply with the requirements of the following standards and references:

Test Standard:

FCC Part 15, Subpart C (15.247) ANSI C63.10-2013

All test items have been performed and recorded as per the above standards.

References Test Guidance:

KDB 558074 D01 15.247 Meas Guidance v05r02

All test items have been performed as a reference to the above KDB test guidance.



4 Test Types and Results

4.1 Radiated Emission and Bandedge Measurement

4.1.1 Limits of Radiated Emission and Bandedge Measurement

Radiated emissions which fall in the restricted bands must comply with the radiated emission limits specified as below table. Other emissions shall be at least 20 dB below the highest level of the desired power:

Frequencies (MHz)	Field Strength (microvolts/meter)	Measurement Distance (meters)
0.009 ~ 0.490	2400/F (kHz)	300
0.490 ~ 1.705	24000/F (kHz)	30
1.705 ~ 30.0	30	30
30 ~ 88	100	3
88 ~ 216	150	3
216 ~ 960	200	3
Above 960	500	3

Note:

- a. The lower limit shall apply at the transition frequencies.
- b. Emission level (dBuV/m) = 20 log Emission level (uV/m).
- c. For frequencies above 1000 MHz, the field strength limits are based on average detector, however, the peak field strength of any emission shall not exceed the maximum permitted average limits, specified above by more than 20 dB under any condition of modulation.



4.1.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Date of Calibration	Due Date of Calibration
Test Receiver ROHDE & SCHWARZ	ESCI	100424	Dec. 31, 2020	Dec. 30, 2021
Spectrum Analyzer ROHDE & SCHWARZ	FSP40	100040	Sep. 16, 2020	Sep. 15, 2021
BILOG Antenna SCHWARZBECK	VULB9168	9168-155	Nov. 03, 2020	Nov. 02, 2021
HORN Antenna SCHWARZBECK	BBHA 9120D	9120D-1170	Nov. 22, 2020	Nov. 21, 2021
HORN Antenna SCHWARZBECK	BBHA 9170	BBHA9170241	Nov. 22, 2020	Nov. 21, 2021
Test Receiver ROHDE & SCHWARZ	ESCI	100424	Dec. 31, 2020	Dec. 30, 2021
Preamplifier Agilent	8447D	2944A10631	Jun. 08, 2020	Jun. 07, 2021
(Below 1GHz)			Jun. 05, 2021	Jun. 04, 2022
Preamplifier KEYSIGHT	83017A	MY53270295	Jun. 08, 2020	Jun. 07, 2021
(Above 1GHz)	03017A	101103270295	Jun. 05, 2021	Jun. 04, 2022
RF Coaxial Cable WOKEN With 5dB PAD	8D-FB	Cable-CH4-01	Aug. 16, 2020	Aug. 15, 2021
RF Coaxial Cable EMCI	EMC102-KM-KM- 3000	150929	Aug. 16, 2020	Aug. 15, 2021
RF Coaxial Cable EMCI	EMC102-KM-KM- 600	150928	Aug. 16, 2020	Aug. 15, 2021
RF signal cable	SUCOFLEX 104	MY	Jun. 08, 2020	Jun. 07, 2021
HUBER+SUHNER		13380+295012/04	Jun. 05, 2021	Jun. 04, 2022
RF signal cable	SUCOFLEX 104	Cable-CH4-03	Jun. 08, 2020	Jun. 07, 2021
HUBER+SUHNER Software BV ADT	ADT_Radiated_ V7.6.15.9.5	(250724) NA	Jun. 05, 2021 NA	Jun. 04, 2022 NA
Antenna Tower inn-co GmbH	MA 4000	010303	NA	NA
Turn Table BV ADT	TT100	TT93021703	NA	NA
Turn Table Controller BV ADT	SC100	SC93021703	NA	NA
Boresight Antenna Fixture	FBA-01	FBA-SIP01	NA	NA
USB Wideband Power Sensor KEYSIGHT	U2021XA	MY55050005/MY55 190004/MY551900 07/MY55210005	Jul. 13, 2020	Jul. 12, 2021

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in HwaYa Chamber 4.



4.1.3 Test Procedures

For Radiated Emission below 30 MHz

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. Parallel, perpendicular, and ground-parallel orientations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test-receiver system was set to Quasi-Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.

Note:

1. The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 9 kHz at frequency below 30 MHz.

For Radiated Emission above 30 MHz

- a. The EUT was placed on the top of a rotating table 0.8 meters (for 30 MHz ~ 1 GHz) / 1.5 meters (for above 1 GHz) above the ground at 3 meter chamber room for test. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The height of antenna is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is below 1 GHz.
- f. The test-receiver system was set to peak and average detected function and specified bandwidth with maximum hold mode when the test frequency is above 1 GHz. If the peak reading value also meets average limit, measurement with the average detector is unnecessary.

Note:

- 1. The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120 kHz for Quasipeak detection (QP) or Peak detection (PK) at frequency below 1 GHz.
- 2. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz and the video bandwidth is 3 MHz for Peak detection (PK) at frequency above 1 GHz.
- 3. For fundamental and harmonic signal measurement, according to ANSI C63.10 section 7.5, the average value = peak value + duty cycle correction factor. The duty cycle correction factor refer to Chapter 3.3 of this report.
- 4. All modes of operation were investigated and the worst-case emissions are reported.

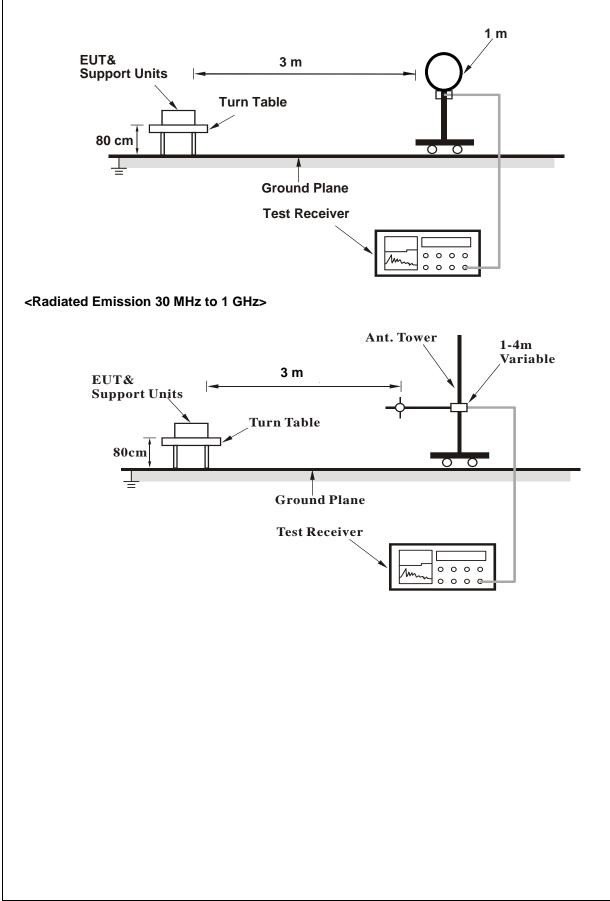
4.1.4 Deviation from Test Standard

No deviation.

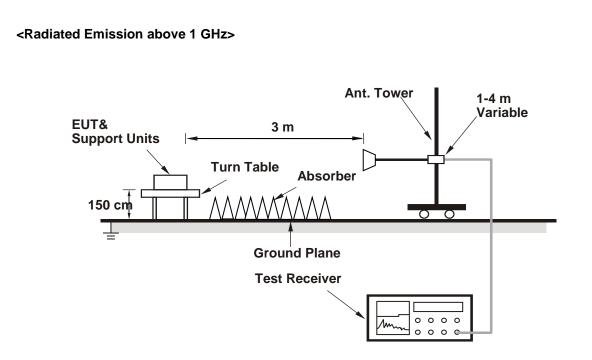


4.1.5 Test Set Up

<Radiated Emission below 30 MHz>







For the actual test configuration, please refer to the attached file (Test Setup Photo).

4.1.6 EUT Operating Conditions

Set the EUT under transmission condition continuously at specific channel frequency.



4.1.7 Test Results

Above 1 GHz Data:

GFSK

RF Mode	TX BT_GFSK	Channel	CH 0:2402 MHz
Frequency Range	1GHz ~ 25GHz	Detector Function	Peak (PK) Average (AV)

		Anter	nna Polarity	& Test Dist	ance : Horiz	zontal at 3 n	n	
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	2390.00	60.76 PK	74.00	-13.24	1.15 H	10	26.30	34.46
2	2390.00	48.96 AV	54.00	-5.04	1.15 H	10	14.50	34.46
3	*2402.00	113.24 PK			1.15 H	10	78.80	34.44
4	*2402.00	82.61 AV			1.15 H	10	48.17	34.44
5	4804.00	46.66 PK	74.00	-27.34	1.35 H	332	44.30	2.36
6	4804.00	16.03 AV	54.00	-37.97	1.35 H	332	13.67	2.36
		Ante	enna Polarit	y & Test Di	stance : Ver	tical at 3 m		
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	2390.00	60.66 PK	74.00	-13.34	3.60 V	248	26.20	34.46
2	2390.00	48.76 AV	54.00	-5.24	3.60 V	248	14.30	34.46
3	*2402.00	108.64 PK			3.60 V	248	74.20	34.44
4	*2402.00	78.01 AV			3.60 V	248	43.57	34.44
5	4804.00	46.36 PK	74.00	-27.64	1.87 V	20	44.00	2.36
6	4804.00	15.73 AV	54.00	-38.27	1.87 V	20	13.37	2.36

Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor(dB/m) + Cable Factor(dB) – Pre-Amplifier Factor(dB)

3. Margin value = Emission Level - Limit value

4. The other emission levels were very low against the limit.



RF Mode	TX BT_GFSK	Channel	CH 39:2441 MHz
Frequency Range	1GHz ~ 25GHz	Detector Function	Peak (PK)
Trequency Range			Average (AV)

	Antenna Polarity & Test Distance : Horizontal at 3 m										
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)			
1	*2441.00	111.39 PK			1.21 H	1	77.00	34.39			
2	*2441.00	80.76 AV			1.21 H	1	46.37	34.39			
3	4882.00	46.64 PK	74.00	-27.36	1.50 H	342	44.10	2.54			
4	4882.00	16.01 AV	54.00	-37.99	1.50 H	342	13.47	2.54			
		Ante	enna Polarit	y & Test Di	stance : Ver	tical at 3 m					

Antenna Polarity	& Test Distance :	Vertical at 3 m
------------------	-------------------	-----------------

No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	*2441.00	106.89 PK			3.58 V	255	72.50	34.39
2	*2441.00	76.26 AV			3.58 V	255	41.87	34.39
3	4882.00	46.44 PK	74.00	-27.56	1.92 V	25	43.90	2.54
4	4882.00	15.81 AV	54.00	-38.19	1.92 V	25	13.27	2.54

Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor(dB/m) + Cable Factor(dB) – Pre-Amplifier Factor(dB)

3. Margin value = Emission Level – Limit value

4. The other emission levels were very low against the limit.



RF Mode	TX BT_GFSK	Channel	CH 78:2480 MHz
Frequency Range	1GHz ~ 25GHz	Detector Function	Peak (PK)
			Average (AV)

	Antenna Polarity & Test Distance : Horizontal at 3 m									
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)		
1	*2480.00	113.34 PK			1.03 H	4	79.00	34.34		
2	*2480.00	82.71 AV			1.03 H	4	48.37	34.34		
3	2483.50	61.90 PK	74.00	-12.10	1.03 H	4	63.80	-1.90		
4	2483.50	31.27 AV	54.00	-22.73	1.03 H	4	33.17	-1.90		
5	4960.00	46.89 PK	74.00	-27.11	1.45 H	338	44.20	2.69		
6	4960.00	16.26 AV	54.00	-37.74	1.45 H	338	13.57	2.69		
		Ante	enna Polarit	y & Test Di	stance : Ver	tical at 3 m				

Antenna Polarity & Test Distance : Vertical at 3 m

No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	*2480.00	108.64 PK			3.63 V	249	74.30	34.34
2	*2480.00	78.01 AV			3.63 V	249	43.67	34.34
3	2483.50	61.60 PK	74.00	-12.40	3.63 V	249	63.50	-1.90
4	2483.50	30.97 AV	54.00	-23.03	3.63 V	249	32.87	-1.90
5	4960.00	46.59 PK	74.00	-27.41	1.82 V	26	43.90	2.69
6	4960.00	15.96 AV	54.00	-38.04	1.82 V	26	13.27	2.69

Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor(dB/m) + Cable Factor(dB) – Pre-Amplifier Factor(dB)

3. Margin value = Emission Level – Limit value

4. The other emission levels were very low against the limit.



8DPSK

RF Mode	TX BT_8DPSK	Channel	CH 0 : 2402 MHz
		Detector Function	Peak (PK)
Frequency Range	1GHz ~ 25GHz	Detector Function	Average (AV)

	Antenna Polarity & Test Distance : Horizontal at 3 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)	
1	2390.00	59.46 PK	74.00	-14.54	1.12 H	0	25.00	34.46	
2	2390.00	48.76 AV	54.00	-5.24	1.12 H	0	14.30	34.46	
3	*2402.00	111.94 PK			1.12 H	0	77.50	34.44	
4	*2402.00	81.31 AV			1.12 H	0	46.87	34.44	
5	4804.00	46.86 PK	74.00	-27.14	1.53 H	346	44.50	2.36	
6	4804.00	16.23 AV	54.00	-37.77	1.53 H	346	13.87	2.36	
		Ante	enna Polarit	y & Test Dis	stance : Ver	tical at 3 m			
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)	

NO	(MHz)	(dBuV/m)	(dBuV/m)	(dB)	(m)	(Degree)	(dBuV)	(dB/m)
1	2390.00	59.66 PK	74.00	-14.34	3.52 V	252	25.20	34.46
2	2390.00	48.56 AV	54.00	-5.44	3.52 V	252	14.10	34.46
3	*2402.00	107.44 PK			3.52 V	252	73.00	34.44
4	*2402.00	76.81 AV			3.52 V	252	42.37	34.44
5	4804.00	46.46 PK	74.00	-27.54	1.92 V	33	44.10	2.36
6	4804.00	15.83 AV	54.00	-38.17	1.92 V	33	13.47	2.36

Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor(dB/m) + Cable Factor(dB) – Pre-Amplifier Factor(dB)

3. Margin value = Emission Level - Limit value

4. The other emission levels were very low against the limit.



RF Mode	TX BT_8DPSK	Channel	CH 39 : 2441 MHz
Frequency Range	1GHz ~ 25GHz	Detector Function	Peak (PK)
Trequency Range			Average (AV)

	Antenna Polarity & Test Distance : Horizontal at 3 m									
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)		
1	*2441.00	110.39 PK			1.11 H	359	76.00	34.39		
2	*2441.00	79.76 AV			1.11 H	359	45.37	34.39		
3	4882.00	46.64 PK	74.00	-27.36	1.51 H	350	44.10	2.54		
4	4882.00	16.01 AV	54.00	-37.99	1.51 H	350	13.47	2.54		
		Ante	enna Polarit	y & Test Di	stance : Ver	tical at 3 m				

Antenna Polarity & Test Distance : Vertical at 3 n	n
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No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	*2441.00	105.89 PK			3.67 V	246	71.50	34.39
2	*2441.00	75.26 AV			3.67 V	246	40.87	34.39
3	4882.00	46.34 PK	74.00	-27.66	1.85 V	24	43.80	2.54
4	4882.00	15.71 AV	54.00	-38.29	1.85 V	24	13.17	2.54

Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor(dB/m) + Cable Factor(dB) – Pre-Amplifier Factor(dB)

3. Margin value = Emission Level – Limit value

4. The other emission levels were very low against the limit.



RF Mode	TX BT_8DPSK	Channel	CH 78:2480 MHz
	1GHz ~ 25GHz	Detector Function	Peak (PK)
Frequency Range		Delector Function	Average (AV)

	Antenna Polarity & Test Distance : Horizontal at 3 m									
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)		
1	*2480.00	112.44 PK			1.26 H	4	78.10	34.34		
2	*2480.00	81.81 AV			1.26 H	4	47.47	34.34		
3	2483.50	58.90 PK	74.00	-15.10	1.26 H	4	60.80	-1.90		
4	2483.50	28.27 AV	54.00	-25.73	1.26 H	4	30.17	-1.90		
5	4960.00	47.19 PK	74.00	-26.81	1.58 H	346	44.50	2.69		
6	4960.00	16.56 AV	54.00	-37.44	1.58 H	346	13.87	2.69		
		Ante	enna Polarit	y & Test Dis	stance : Ver	tical at 3 m				

Antenna Polarity & Test Distance : Vertical at 3 m

No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	*2480.00	107.84 PK			3.55 V	249	73.50	34.34
2	*2480.00	77.21 AV			3.55 V	249	42.87	34.34
3	2483.50	58.70 PK	74.00	-15.30	3.55 V	249	60.60	-1.90
4	2483.50	28.07 AV	54.00	-25.93	3.55 V	249	29.97	-1.90
5	4960.00	46.89 PK	74.00	-27.11	1.92 V	23	44.20	2.69
6	4960.00	16.26 AV	54.00	-37.74	1.92 V	23	13.57	2.69

Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor(dB/m) + Cable Factor(dB) – Pre-Amplifier Factor(dB)

3. Margin value = Emission Level – Limit value

4. The other emission levels were very low against the limit.



9 kHz ~ 30 MHz Data:

The amplitude of spurious emissions attenuated more than 20 dB below the permissible value is not required to be report.

30 MHz ~ 1 GHz Worst-Case Data:

RF Mode	TX BT_GFSK	Channel	CH 0:2402 MHz
Frequency Range	30MHz ~ 1GHz	Detector Function	Quasi-Peak (QP)

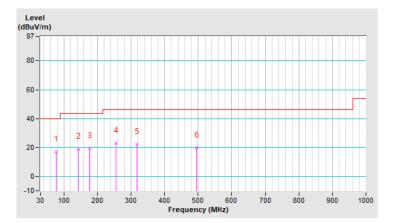
	Antenna Polarity & Test Distance : Horizontal at 3 m										
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)			
1	77.80	17.4 QP	40.0	-22.6	1.00 H	168	40.0	-22.6			
2	143.87	18.8 QP	43.5	-24.7	2.00 H	106	37.1	-18.3			
3	177.61	19.3 QP	43.5	-24.2	1.50 H	112	38.7	-19.4			
4	254.93	23.1 QP	46.0	-22.9	1.50 H	9	42.5	-19.4			
5	316.78	22.1 QP	46.0	-23.9	2.00 H	4	39.3	-17.2			
6	495.32	20.0 QP	46.0	-26.0	1.50 H	152	32.9	-12.9			

Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor(dB/m) + Cable Factor(dB) – Pre-Amplifier Factor(dB)

- 3. Margin value = Emission Level Limit value
- 4. The other emission levels were very low against the limit of frequency range 30MHz~1000MHz.
- 5. The emission levels were very low against the limit of frequency range 9kHz~30MHz: the amplitude of spurious emissions attenuated more than 20 dB below the permissible value to be report.

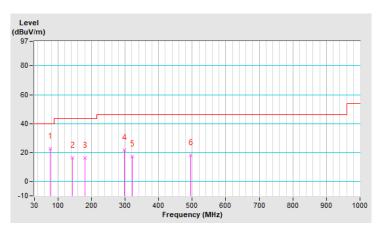


RF Mode	TX BT_GFSK	Channel	CH 0:2402 MHz
Frequency Range	30MHz ~ 1GHz	Detector Function	Quasi-Peak (QP)

	Antenna Polarity & Test Distance : Vertical at 3 m										
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)			
1	76.39	22.7 QP	40.0	-17.3	2.00 V	205	45.0	-22.3			
2	143.87	16.1 QP	43.5	-27.4	1.50 V	19	34.4	-18.3			
3	180.42	16.1 QP	43.5	-27.4	1.50 V	16	35.8	-19.7			
4	297.10	21.9 QP	46.0	-24.1	2.00 V	111	39.6	-17.7			
5	321.00	17.1 QP	46.0	-28.9	1.50 V	208	34.1	-17.0			
6	495.32	17.9 QP	46.0	-28.1	1.00 V	48	30.8	-12.9			

Remarks:

- 1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
- 2. Correction Factor(dB/m) = Antenna Factor(dB/m) + Cable Factor(dB) Pre-Amplifier Factor(dB)
- 3. Margin value = Emission Level Limit value
- 4. The other emission levels were very low against the limit of frequency range 30MHz~1000MHz.
- 5. The emission levels were very low against the limit of frequency range 9kHz~30MHz: the amplitude of spurious emissions attenuated more than 20 dB below the permissible value to be report.





4.2 Conducted Emission Measurement

4.2.1 Limits of Conducted Emission Measurement

	Conducted I	Limit (dBuV)
Frequency (MHz)	Quasi-Peak	Average
0.15 - 0.5	66 - 56	56 - 46
0.50 - 5.0	56	46
5.0 - 30.0	60	50

Note: 1. The lower limit shall apply at the transition frequencies.

2. The limit decreases in line with the logarithm of the frequency in the range of 0.15 to 0.50 MHz.

4.2.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Date of Calibration	Due Date of Calibration
Test Receiver ROHDE & SCHWARZ	ESCI	100613	Dec. 04, 2020	Dec. 03, 2021
RF signal cable Woken	5D-FB	Cable-cond1-01	Jan. 16, 2021	Jan. 15, 2022
LISN/AMN ROHDE & SCHWARZ (EUT)	ENV216	101826	Feb. 25, 2021	Feb. 24, 2022
LISN/AMN ROHDE & SCHWARZ (Peripheral)	ESH3-Z5	100311	Aug. 28, 2020	Aug. 27, 2021
Software ADT	BV ADT_Cond_ V7.3.7.4	NA	NA	NA

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in HwaYa Shielded Room 1. (Conduction 1).

3. The VCCI Site Registration No. is C-12040.



4.2.3 Test Procedures

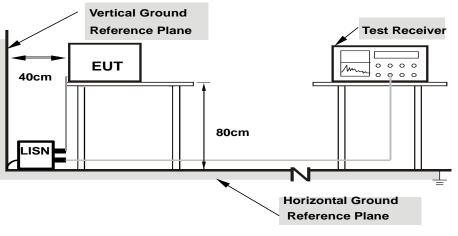
- a. The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN). Other support units were connected to the power mains through another LISN. The two LISNs provide 50 ohm/ 50 uH of coupling impedance for the measuring instrument.
- b. Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- c. The frequency range from 150 kHz to 30 MHz was searched. Emission levels under (Limit 20 dB) was not recorded.

Note: The resolution bandwidth and video bandwidth of test receiver is 9 kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15 MHz - 30 MHz.

4.2.4 Deviation from Test Standard

No deviation.

4.2.5 Test Setup



Note: 1.Support units were connected to second LISN. 2.Both of LISNs (AMN) are 80 cm from EUT and at least 80 from other units and other metal planes

For the actual test configuration, please refer to the attached file (Test Setup Photo).

4.2.6 EUT Operating Condition

Set the EUT under transmission condition continuously at specific channel frequency.



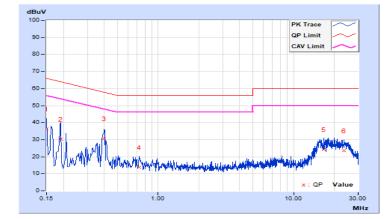
4.2.7 Test Results

Frequency Range	150kHz ~ 30MHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	120Vac, 60Hz	Environmental Conditions	24℃, 69%RH
Tested by	Edison Lee	Test Date	2021/4/17

	Phase Of Power : Line (L)									
No	Frequency	Correction Factor	Reading Value (dBuV)		-		el Limit (dBuV)		Margin (dB)	
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.15000	10.07	26.27	1.92	36.34	11.99	66.00	56.00	-29.66	-44.01
2	0.19000	10.08	20.27	0.77	30.35	10.85	64.04	54.04	-33.69	-43.19
3	0.39800	10.09	20.42	3.70	30.51	13.79	57.90	47.90	-27.39	-34.11
4	0.72600	10.12	3.81	2.96	13.93	13.08	56.00	46.00	-42.07	-32.92
5	16.75000	10.40	13.92	1.04	24.32	11.44	60.00	50.00	-35.68	-38.56
6	23.71000	10.36	13.22	0.52	23.58	10.88	60.00	50.00	-36.42	-39.12

Remarks:

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value

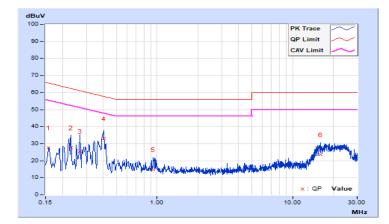


Frequency Range	150kHz ~ 30MHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	120Vac, 60Hz	Environmental Conditions	24℃, 69%RH
Tested by	Edison Lee	Test Date	2021/4/17

	Phase Of Power : Neutral (N)									
No	Frequency	equency Correction Reading Value Factor (dBuV)		-	Emission Level (dBuV)		Limit (dBuV)		Margin (dB)	
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.15800	10.08	17.52	2.53	27.60	12.61	65.57	55.57	-37.97	-42.96
2	0.23000	10.08	17.68	1.17	27.76	11.25	62.45	52.45	-34.69	-41.20
3	0.26992	10.09	15.39	0.45	25.48	10.54	61.12	51.12	-35.64	-40.58
4	0.40179	10.10	22.89	5.37	32.99	15.47	57.82	47.82	-24.83	-32.35
5	0.93800	10.14	4.76	1.36	14.90	11.50	56.00	46.00	-41.10	-34.50
6	16.06600	10.55	13.06	1.99	23.61	12.54	60.00	50.00	-36.39	-37.46

Remarks:

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value



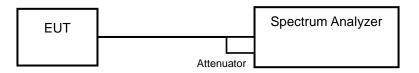


4.3 Number of Hopping Frequency Used

4.3.1 Limits of Hopping Frequency Used Measurement

At least 15 channels frequencies, and should be equally spaced.

4.3.2 Test Setup



4.3.3 Test Instruments

Refer to section 4.1.2 to get information of above instrument.

4.3.4 Test Procedure

- a. Check the calibration of the measuring instrument (SA) using either an internal calibrator or a known signal from an external generator.
- b. Turn on the EUT and connect its antenna terminal to measurement via a low loss cable. Then set it to any one measured frequency within its operating range and make sure the instrument is operated in its linear range.
- c. Set the SA on MaxHold Mode, and then keep the EUT in hopping mode. Record all the signals from each channel until each one has been recorded.
- d. Set the SA on View mode and then plot the result on SA screen.
- e. Repeat above procedures until all frequencies measured were complete.

4.3.5 Deviation from Test Standard

No deviation.

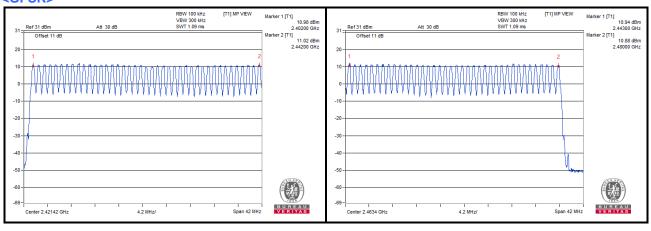




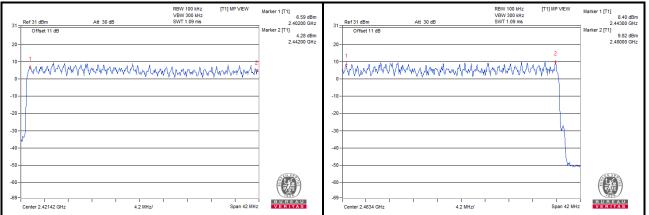
4.3.6 Test Results

There are 79 hopping frequencies in the hopping mode. Please refer to next page for the test result. On the plots, it shows that the hopping frequencies are equally spaced.

<GFSK>



<8DPSK>



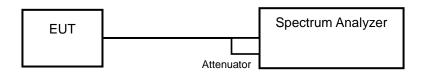


4.4 Dwell Time on Each Channel

4.4.1 Limits of Dwell Time on Each Channel Measurement

The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.

4.4.2 Test Setup



4.4.3 Test Instruments

Refer to section 4.1.2 to get information of above instrument.

4.4.4 Test Procedures

- a. Check the calibration of the measuring instrument (SA) using either an internal calibrator or a known signal from an external generator.
- b. Turn on the EUT and connect its antenna terminal to measurement via a low loss cable. Then set it to any one measured frequency within its operating range and make sure the instrument is operated in its linear range.
- c. Adjust the center frequency of SA on any frequency be measured and set SA to zero span mode. And then, set RBW and VBW of spectrum analyzer to proper value.
- d. Measure the time duration of one transmission on the measured frequency. And then plot the result with time difference of this time duration.
- e. Repeat above procedures until all different time-slot modes have been completed.
- 4.4.5 Deviation from Test Standard

No deviation.

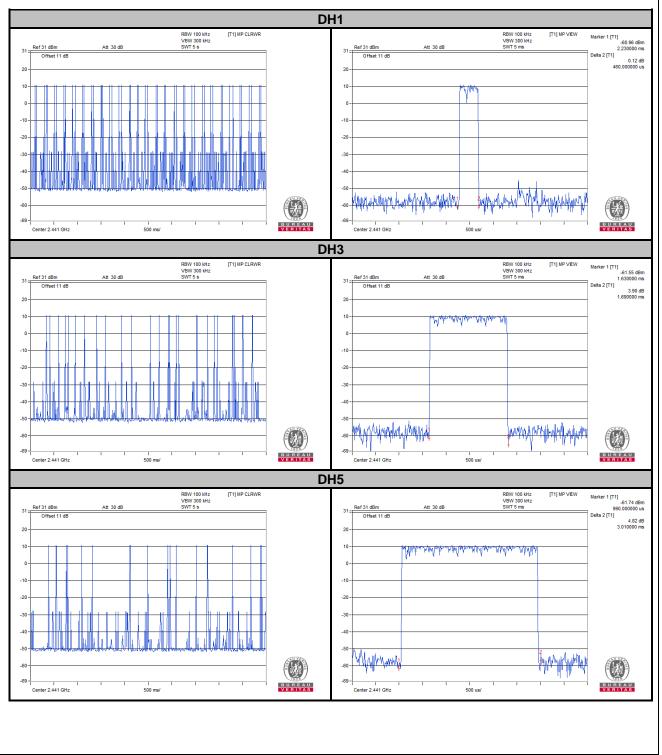


4.4.6 Test Results

GFSK

Mode	Number of Transmission in a 31.6 (79 Hopping*0.4)	Length of Transmission Time (msec)	Result (msec)	Limit (msec)
DH1	50 (times / 5 sec) * 6.32 = 316 tim	es 0.46	145.36	400
DH3	25 (times / 5 sec) * 6.32 = 158 tim	es 1.69	267.02	400
DH5	17 (times / 5 sec) * 6.32 = 108 tim	es 3.01	325.08	400

Note: Test plots of the transmitting time slot are shown as below.

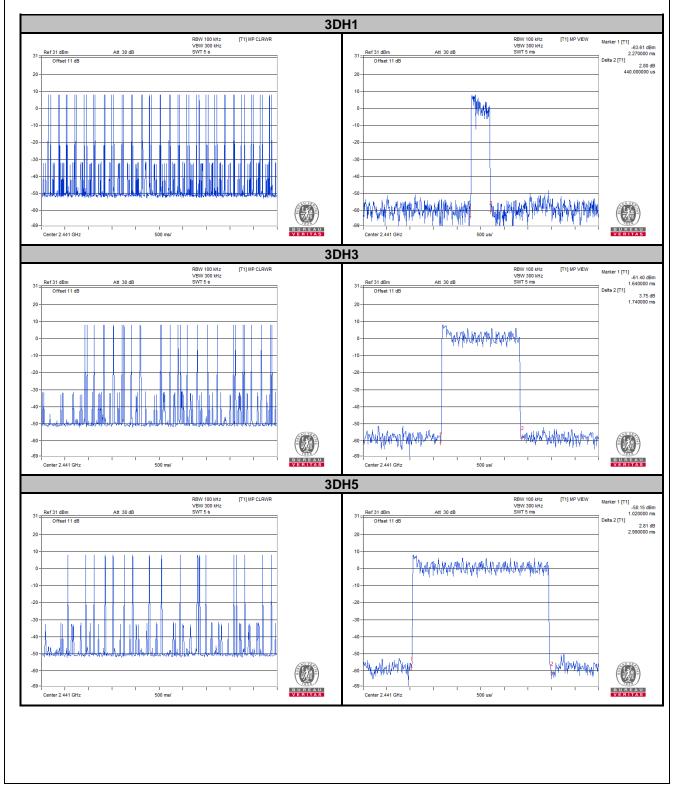




8DPSK

Mode	Number of Transmission in a 31.6 (79 Hopping*0.4)	Length of Transmission Time (msec)	Result (msec)	Limit (msec)
3DH1	50 (times / 5 sec) * 6.32 = 316 times	0.44	139.04	400
3DH3	26 (times / 5 sec) * 6.32 = 165 times	1.74	287.1	400
3DH5	18 (times / 5 sec) * 6.32 = 114 times	2.99	340.86	400

Note: Test plots of the transmitting time slot are shown as below.



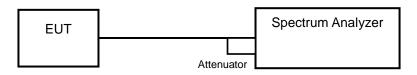


4.5 Channel Bandwidth

4.5.1 Limits of Channel Bandwidth Measurement

For frequency hopping system operating in the 2400-2483.5 MHz, if the 20 dB bandwidth of hopping channel is greater than 25 kHz, two-thirds 20 dB bandwidth of hopping channel shell be a minimum limit for the hopping channel separation.

4.5.2 Test Setup



4.5.3 Test Instruments

Refer to section 4.1.2 to get information of above instrument.

4.5.4 Test Procedure

- a. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
- b. Turn on the EUT and connect it to measurement instrument. Then set it to any one convenient frequency within its operating range. Set a reference level on the measuring instrument equal to the highest peak value.
- c. Measure the frequency difference of two frequencies that were attenuated 20 dB from the reference level. Record the frequency difference as the emission bandwidth.
- d. Repeat above procedures until all frequencies measured were complete.

4.5.5 Deviation from Test Standard

No deviation.

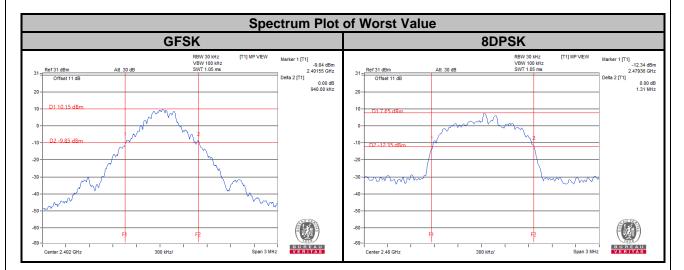
4.5.6 EUT Operating Condition

The software provided by client enabled the EUT to transmit and receive data at lowest, middle and highest channel frequencies individually.



4.5.7 Test Results

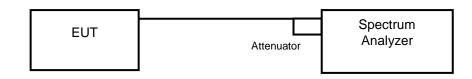
Channel	Frequency	20 dB Bandwidth (MHz)			
Channel	(MHz)	GFSK	8DPSK		
0	2402	0.94	1.29		
39	2441	0.94	1.29		
78	2480	0.94	1.31		





4.6 Occupied Bandwidth Measurement

4.6.1 Test Setup



4.6.2 Test Instruments

Refer to section 4.1.2 to get information of above instrument

4.6.3 Test Procedure

The transmitter output was connected to the spectrum analyzer through an attenuator. The bandwidth of the fundamental frequency was measured by spectrum analyzer with resolution bandwidth in the range of 1 % to 5 % of the anticipated emission bandwidth, and a video bandwidth at least 3x the resolution bandwidth and set the detector to sampling. The width of a frequency band such that, below the lower and above the upper frequency limits, the mean powers emitted are each equal to a specified percentage 0.5 % of the total mean power of a given emission.

4.6.4 Deviation from Test Standard

No deviation.

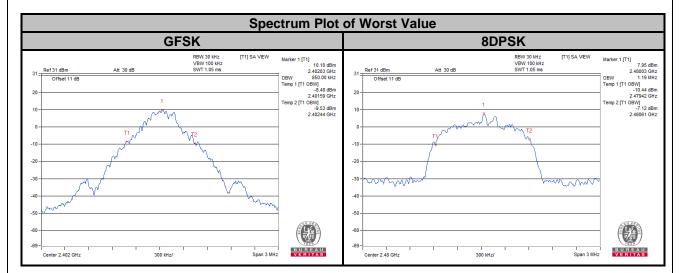
4.6.5 EUT Operating Conditions

The software provided by client to enable the EUT under transmission condition continuously at lowest, middle and highest channel frequencies individually.



4.6.6 Test Results

Channel	Frequency	Occupied Bandwidth (MHz)				
	(MHz)	GFSK	8DPSK			
0	2402	0.85	1.18			
39	2441	0.85	1.18			
78	2480	0.85	1.19			



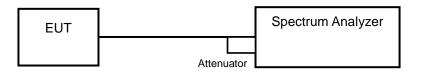


4.7 Hopping Channel Separation

4.7.1 Limits of Hopping Channel Separation Measurement

At least 25 kHz or two-third of 20 dB hopping channel bandwidth (whichever is greater).

4.7.2 Test Setup



4.7.3 Test Instruments

Refer to section 4.1.2 to get information of above instrument.

4.7.4 Test Procedure

Measurement Procedure REF

- a. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
- b. Turn on the EUT and connect it to measurement instrument. Then set it to any one convenient frequency within its operating range.
- c. By using the MaxHold function record the separation of two adjacent channels.
- d. Measure the frequency difference of these two adjacent channels by SA MARK function. And then plot the result on SA screen.
- e. Repeat above procedures until all frequencies measured were complete.

4.7.5 Deviation from Test Standard

No deviation.

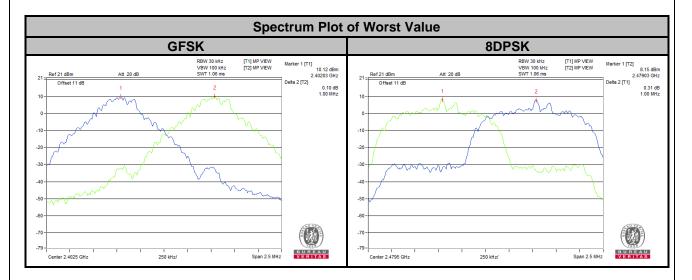


4.7.6 Test Results

Channel	Freq. (MHz)	Adjacent Channel Separation (MHz)			dB Ith (MHz)	Minimum Limit (MHz)		Pass / Fail
		GFSK	8DPSK	GFSK	8DPSK	GFSK	8DPSK	
0	2402	1.00	1.00	0.94	1.29	0.63	0.86	Pass
39	2441	1.00	1.00	0.94	1.29	0.63	0.86	Pass
78	2480	1.00	1.00	0.94	1.31	0.63	0.88	Pass

Note:

1. The minimum limit is two-third 20 dB bandwidth.





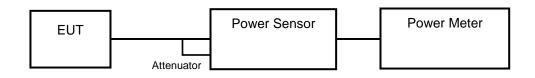
4.8 Maximum Output Power

4.8.1 Limits of Maximum Output Power Measurement

For frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 nonoverlapping hopping channels: 1 watt.

For all other frequency hopping systems in the 2400-2483.5 MHz band: 0.125 watts.

4.8.2 Test Setup



4.8.3 Test Instruments

Refer to section 4.1.2 to get information of above instrument.

4.8.4 Test Procedure

A peak power sensor was used on the output port of the EUT. A power meter was used to read the response of the peak power sensor. Record the power level.

Average power sensor was used to perform output power measurement, trigger and gating function of wide band power meter is enabled to measure max output power of TX on burst. Duty factor is not added to measured value.

4.8.5 Deviation from Test Standard

No deviation.

4.8.6 EUT Operating Condition

The software provided by client enabled the EUT to transmit and receive data at lowest, middle and highest channel frequencies individually.



4.8.7 Test Results

<GFSK>

Channel	Freq. (MHz)	Peak Power		Average Power		Power Limit	Pass / Fail	
		(mW)	(dBm)	(mW)	(dBm)	(mW)	Fass/Faii	
0	2402	18.239	12.61	17.824	12.51	125 / 1000 Note	Pass	
39	2441	16.406	12.15	15.812	11.99	125 / 1000 Note	Pass	
78	2480	18.923	12.77	14.791	11.70	125 / 1000 Note	Pass	

Note: RF Output Power limit depends on the operating channel numbers, please refer to section 4.3 of the results.

<8DPSK>

Channel		Peak Power		Average Power		Power Limit	Deco / Foil
	Freq. (MHz)	(mW)	(dBm)	(mW)	(dBm)	(mW)	Pass / Fail
0	2402	19.187	12.83	11.83	10.73	125 / 1000 Note	Pass
39	2441	18.408	12.65	10.069	10.03	125 / 1000 Note	Pass
78	2480	18.707	12.72	12.589	11.00	125 / 1000 Note	Pass

Note: RF Output Power limit depends on the operating channel numbers, please refer to section 4.3 of the results.



4.9 Conducted Out of Band Emission Measurement

4.9.1 Limits Of Conducted Out of Band Emission Measurement

Below -20 dB of the highest emission level of operating band (in 100 kHz RBW).

4.9.2 Test Instruments

Refer to section 4.1.2 to get information of above instrument.

4.9.3 Test Procedure

The transmitter output was connected to the spectrum analyzer via a low lose cable. Set both RBW and VBW of spectrum analyzer to 100 kHz and 300 kHz with suitable frequency span including 100 MHz bandwidth from band edge. The band edges was measured and recorded.

4.9.4 Deviation from Test Standard

No deviation.

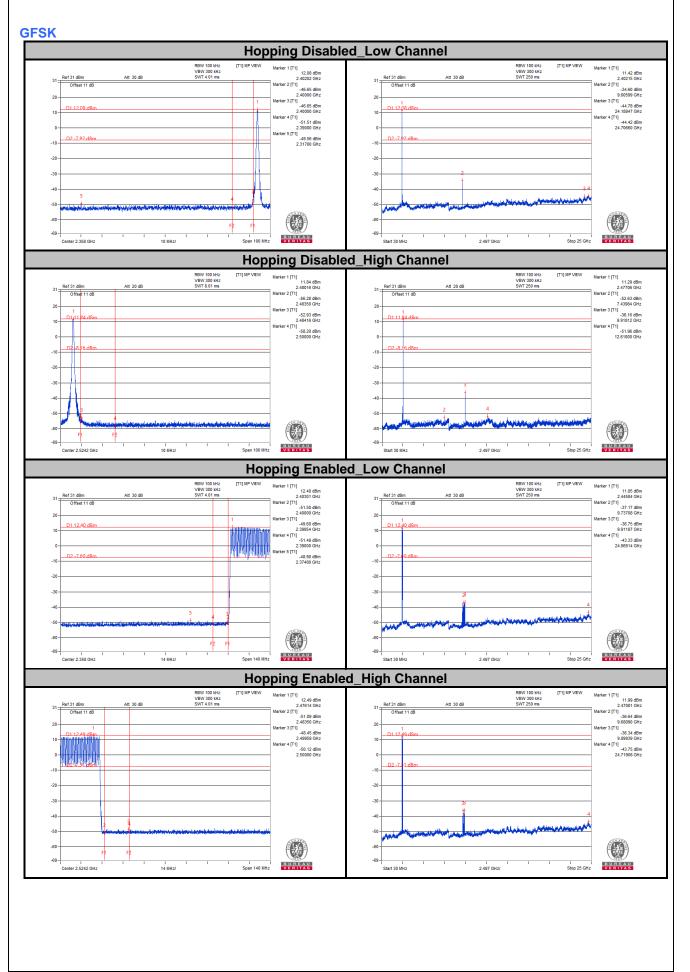
4.9.5 EUT Operating Condition

The software provided by client enabled the EUT to transmit and receive data at lowest, middle and highest channel frequencies individually.

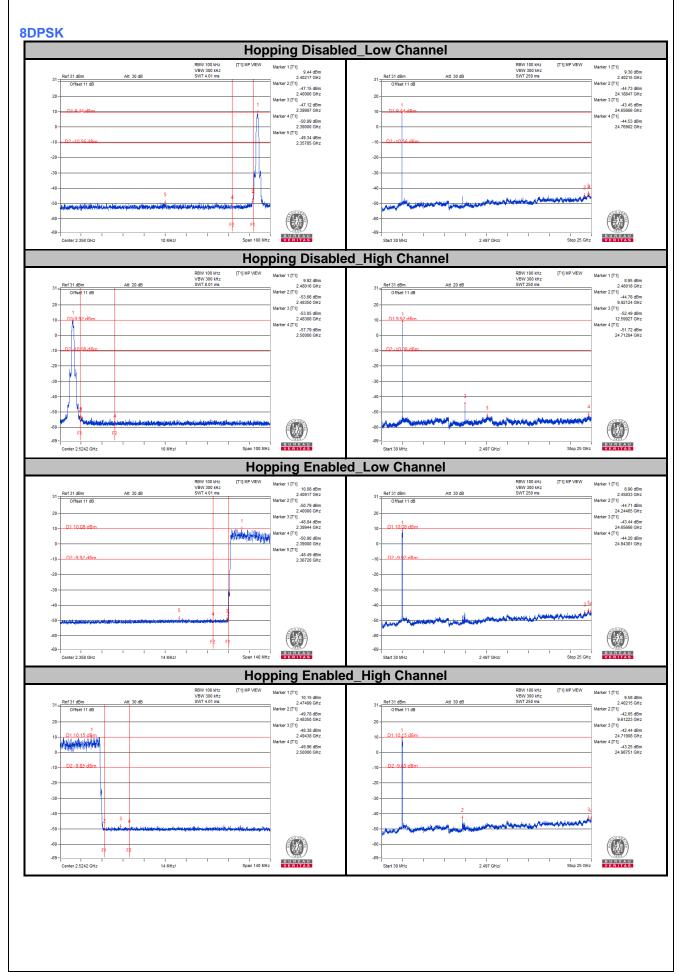
4.9.6 Test Results

The spectrum plots are attached on the following images. D1 line indicates the highest level, D2 line indicates the 20 dB offset below D1. It shows compliance with the requirement.











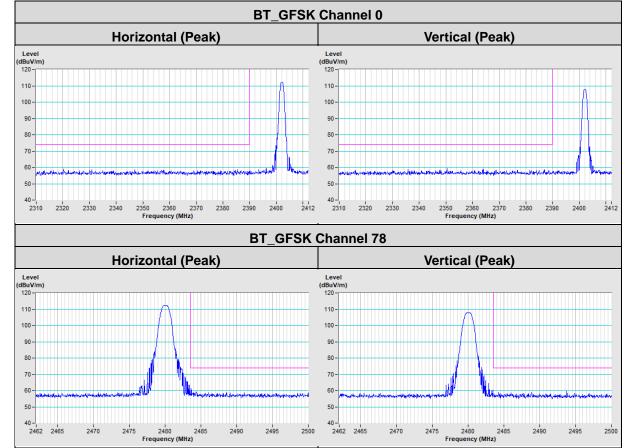
5 Pictures of Test Arrangements

Please refer to the attached file (Test Setup Photo).



Annex A- Band Edge Measurement

GFSK





BT_8DPSK Channel 0 Horizontal (Peak) Vertical (Peak) Level (dBuV/m) 120 -Level (dBuV/m) 120-110-110-100 100 90 90 80 80 70· 70 60· 60 **50** · 50-40-2310 40-2310 2320 2330 2340 2350 2360 2370 Frequency (MHz) 2380 2390 2400 2412 2320 2330 2340 2350 2360 2370 Frequency (MHz) 2380 2390 2400 2412 **BT_8DPSK Channel 78** Horizontal (Peak) Vertical (Peak) Level dBuV/m) 120 -Level (dBuV/m) 120 -110 110 100 100 90 90 80 80 70 70 <mark>60</mark> · 60 50 -**50** · 40-40 -2480 2485 Frequency (MHz) 2480 2485 Frequency (MHz) 2470 2500 2462 2465 2475 2490 2495 2462 2465 2470 2475 2490 2495 2500



Appendix – Information of the Testing Laboratories

We, Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch, were founded in 1988 to provide our best service in EMC, Radio, Telecom and Safety consultation. Our laboratories are FCC recognized accredited test firms and accredited according to ISO/IEC 17025.

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The address and road map of all our labs can be found in our web site also.

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